

**Search Notes**

Application/Control No.

10/600,770

Examiner

David Buttner

Applicant(s)/Patent under  
Reexamination

WU, SHENSHEN

Art Unit

1712

**SEARCHED**

Class	Subclass	Date	Examiner
528	49	6/27/2005	DB
528	54	6/27/2005	DB
528	55	6/27/2005	DB
528	58	6/27/2005	DB
528	61	6/27/2005	DB
528	65	6/27/2005	DB
528	66	6/27/2005	DB
528	76	6/27/2005	DB
528	80	6/27/2005	DB
528	83	6/27/2005	DB
473	374	6/27/2005	DB
473	377	6/27/2005	DB
473	378	6/27/2005	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/27/2005	DB